


<b>Search Notes</b>  	<b>Application/Control No.</b>  10584133	<b>Applicant(s)/Patent Under Reexamination</b>  TAKEI ET AL.
	<b>Examiner</b>  DAVID NHU	<b>Art Unit</b>  2895

SEARCHED			
Class	Subclass	Date	Examiner
438	758, 706, 712, 724, 744, 757, 782, 680	8/8/2009	DN
257	E21.17; 218; 229; 245; 267; 329; 332	2/20/2010	DN

SEARCH NOTES		
Search Notes	Date	Examiner
SEARCHED IN EAST	8/10/2009	DN
SEARCHED IN EAST	2/20/2010	DN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
438	758, 725, 782	8/10/2009	DN

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